

IRF3704PbF  
IRF3704SPbF  
IRF3704LPbF

HEXFET® Power MOSFET

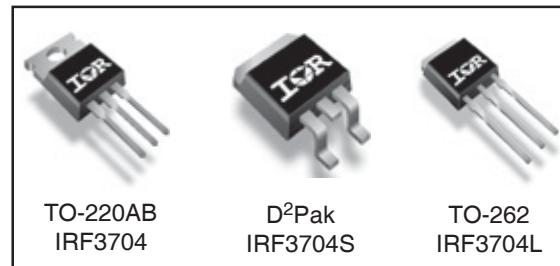
V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
20V	9.0mΩ	77A <sup>⑤</sup>

### Applications

- High Frequency DC-DC Isolated Converters with Synchronous Rectification for Telecom and Industrial use
- High Frequency Buck Converters for Computer Processor Power
- Lead-Free

### Benefits

- Ultra-Low Gate Impedance
- Very Low R<sub>DS(on)</sub>
- Fully Characterized Avalanche Voltage and Current



### Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
V <sub>DS</sub>	Drain-Source Voltage	20	V
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	77 <sup>⑤</sup>	A
I <sub>D</sub> @ T <sub>C</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	64	
I <sub>DM</sub>	Pulsed Drain Current <sup>①</sup>	308	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Maximum Power Dissipation <sup>③</sup>	87	W
P <sub>D</sub> @ T <sub>C</sub> = 70°C	Maximum Power Dissipation <sup>③</sup>	61	W
	Linear Derating Factor	0.59	mW/°C
T <sub>J</sub> , T <sub>STG</sub>	Junction and Storage Temperature Range	-55 to + 175	°C

### Thermal Resistance

	Parameter	Typ.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case	—	1.73	
R <sub>θCS</sub>	Case-to-Sink, Flat, Greased Surface <sup>④</sup>	0.50	—	°C/W
R <sub>θJA</sub>	Junction-to-Ambient <sup>④</sup>	—	62	
R <sub>θJA</sub>	Junction-to-Ambient (PCB mount)*	—	40	

\* When mounted on 1" square PCB (FR-4 or G-10 Material).  
For recommended footprint and soldering techniques refer to application note #AN-994

Notes ① through ④ are on page 10

[www.irf.com](http://www.irf.com)

# IRF3704/S/LPbF

International  
Rectifier

## Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	20	—	—	V	$V_{\text{GS}} = 0\text{V}$ , $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.021	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	6.3	9.0	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}$ , $I_D = 15\text{A}$ ③
		—	9.8	13.5		$V_{\text{GS}} = 4.5\text{V}$ , $I_D = 12\text{A}$ ③
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	1.0	—	3.0	V	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 250\mu\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	20	$\mu\text{A}$	$V_{\text{DS}} = 16\text{V}$ , $V_{\text{GS}} = 0\text{V}$
		—	—	100		$V_{\text{DS}} = 16\text{V}$ , $V_{\text{GS}} = 0\text{V}$ , $T_J = 125^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	200	$\text{nA}$	$V_{\text{GS}} = 16\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{\text{GS}} = -16\text{V}$

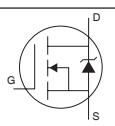
## Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

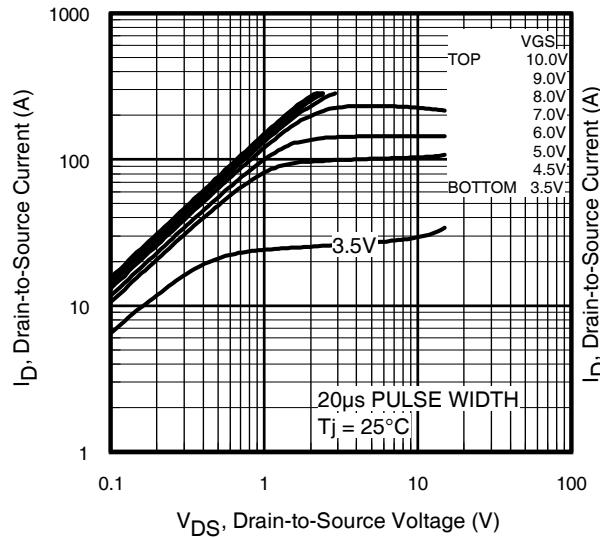
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$g_{\text{fs}}$	Forward Transconductance	42	—	—	S	$V_{\text{DS}} = 10\text{V}$ , $I_D = 57\text{A}$
$Q_g$	Total Gate Charge	—	19	—	nC	$I_D = 28.4\text{A}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	8.1	—	nC	$V_{\text{DS}} = 10\text{V}$
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	6.4	—	nC	$V_{\text{GS}} = 4.5\text{V}$ ③
$Q_{\text{oss}}$	Output Gate Charge	—	16	24	nC	$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 10\text{V}$
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	8.4	—	ns	$V_{\text{DD}} = 10\text{V}$
$t_r$	Rise Time	—	98	—		$I_D = 28.4\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	12	—		$R_G = 1.8\Omega$
$t_f$	Fall Time	—	5.0	—		$V_{\text{GS}} = 4.5\text{V}$ ③
$C_{\text{iss}}$	Input Capacitance	—	1996	—	pF	$V_{\text{GS}} = 0\text{V}$
$C_{\text{oss}}$	Output Capacitance	—	1085	—		$V_{\text{DS}} = 10\text{V}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	155	—		$f = 1.0\text{MHz}$

## Avalanche Characteristics

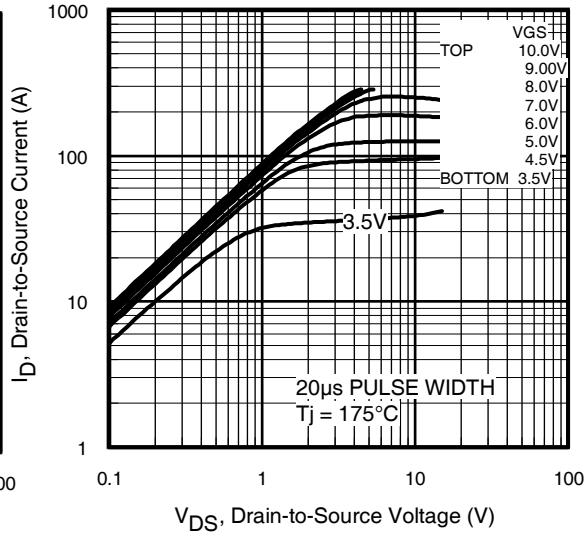
Symbol	Parameter	Typ.	Max.	Units
$E_{\text{AS}}$	Single Pulse Avalanche Energy ②	—	216	mJ
$I_{\text{AR}}$	Avalanche Current ①	—	71	A

## Diode Characteristics

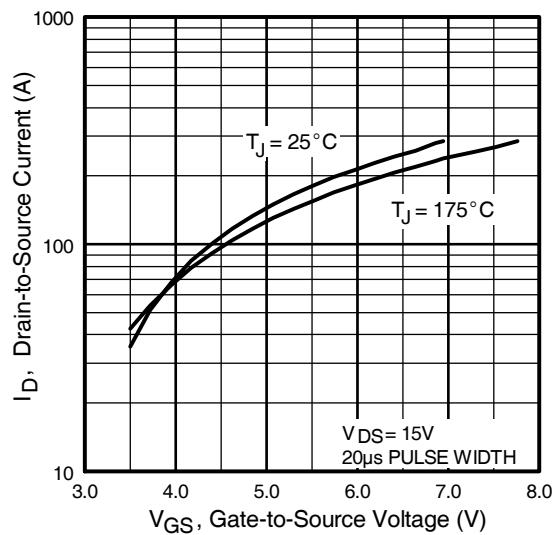
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	77 ⑤	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	308		
$V_{\text{SD}}$	Diode Forward Voltage	—	0.88	1.3	V	$T_J = 25^\circ\text{C}$ , $I_S = 35.5\text{A}$ , $V_{\text{GS}} = 0\text{V}$ ③
		—	0.82	—		$T_J = 125^\circ\text{C}$ , $I_S = 35.5\text{A}$ , $V_{\text{GS}} = 0\text{V}$ ③
$t_{\text{rr}}$	Reverse Recovery Time	—	38	57	ns	$T_J = 25^\circ\text{C}$ , $I_F = 35.5\text{A}$ , $V_R=20\text{V}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	45	68	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ③
$t_{\text{rr}}$	Reverse Recovery Time	—	41	62	ns	$T_J = 125^\circ\text{C}$ , $I_F = 35.5\text{A}$ , $V_R=20\text{V}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	50	75	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ③



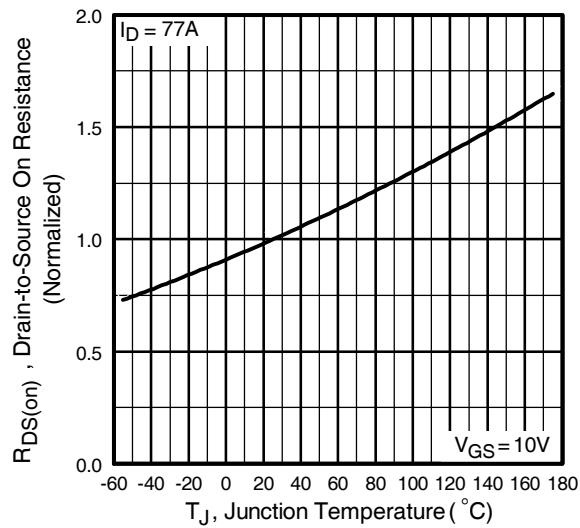
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



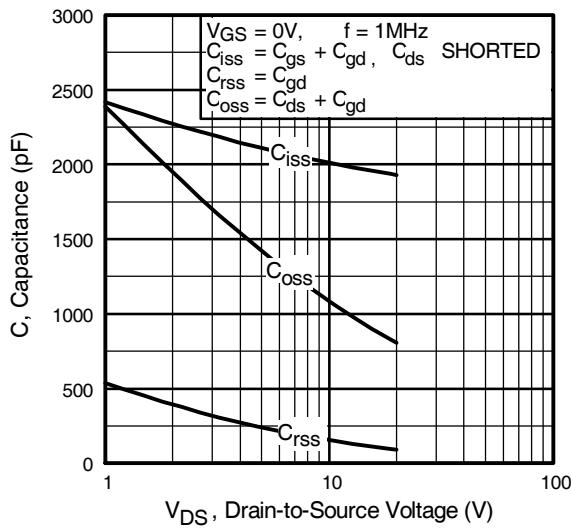
**Fig 3.** Typical Transfer Characteristics



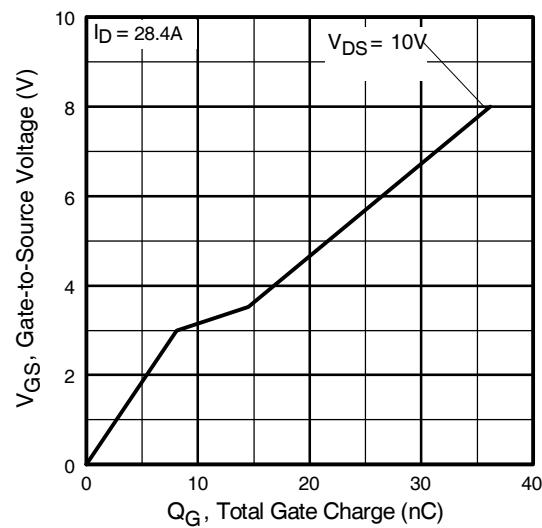
**Fig 4.** Normalized On-Resistance Vs. Temperature

# IRF3704/S/LPbF

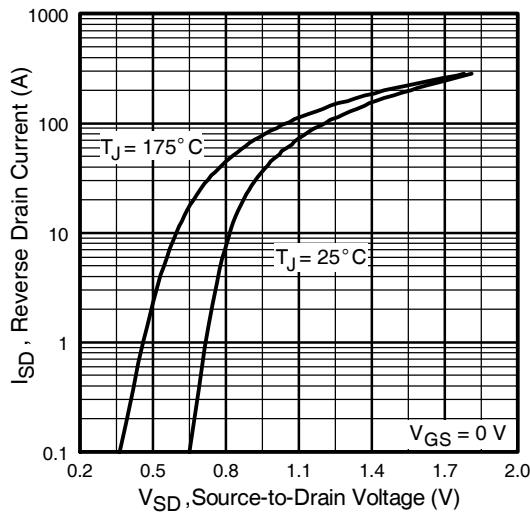
International  
**IR** Rectifier



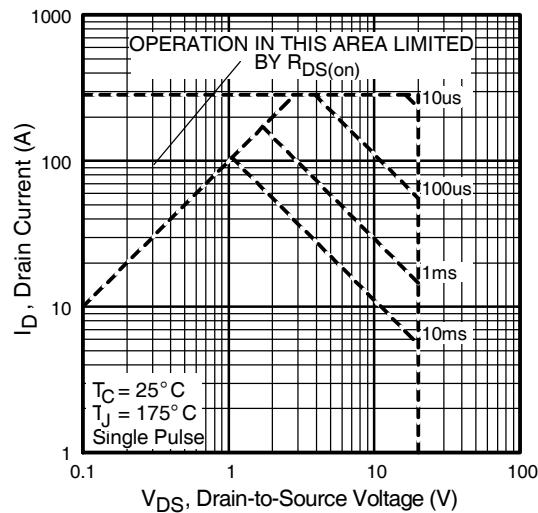
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



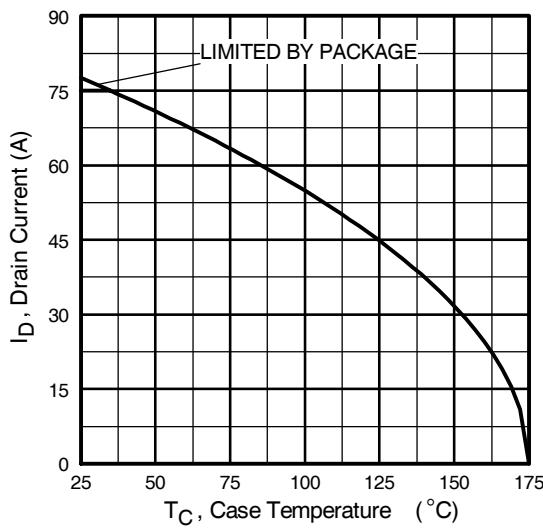
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



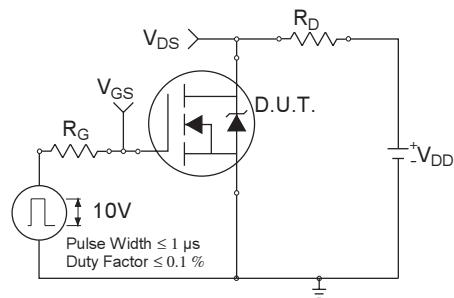
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



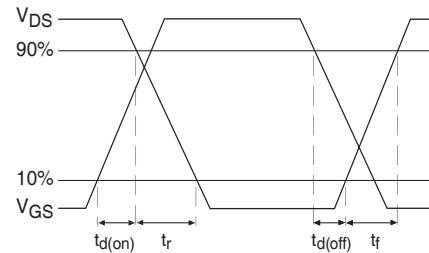
**Fig 8.** Maximum Safe Operating Area



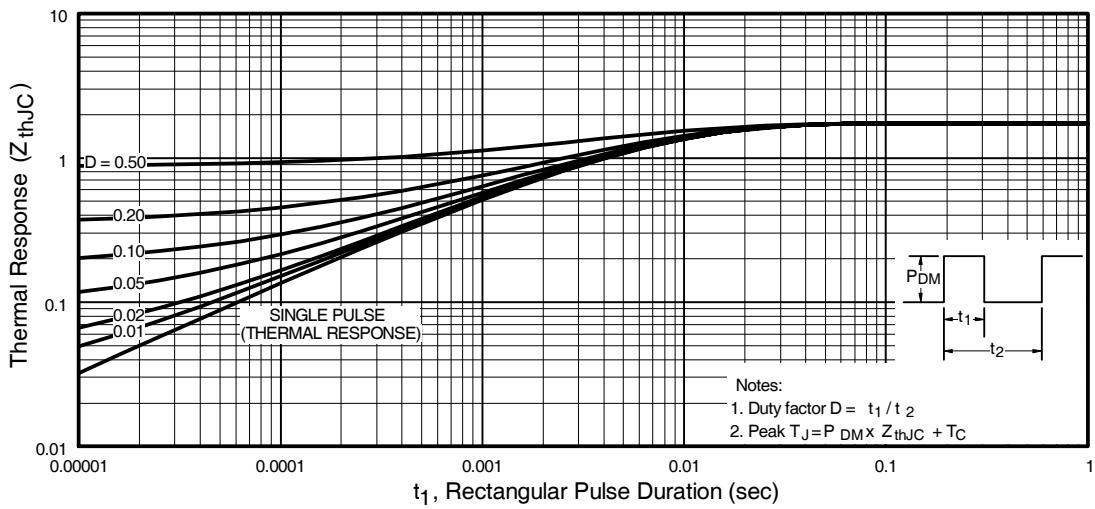
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



**Fig 10a.** Switching Time Test Circuit



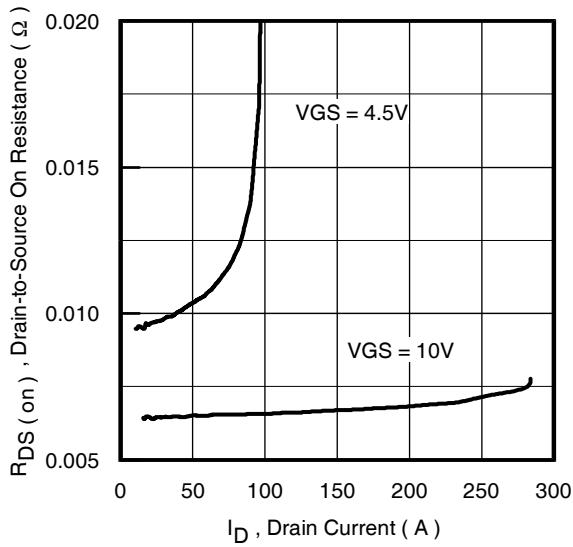
**Fig 10b.** Switching Time Waveforms



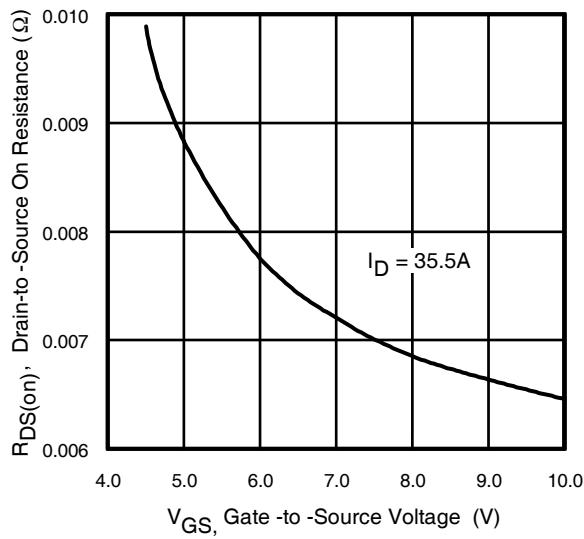
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

# IRF3704/S/LPbF

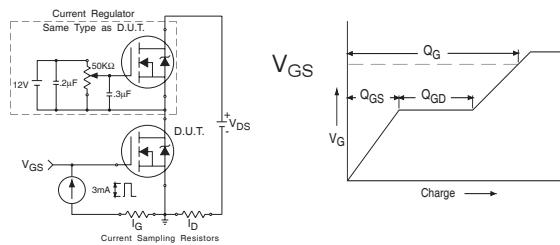
International  
**IR** Rectifier



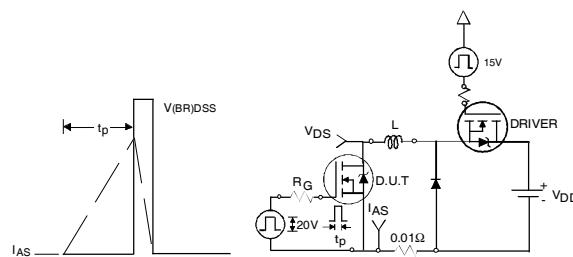
**Fig 12.** On-Resistance Vs. Drain Current



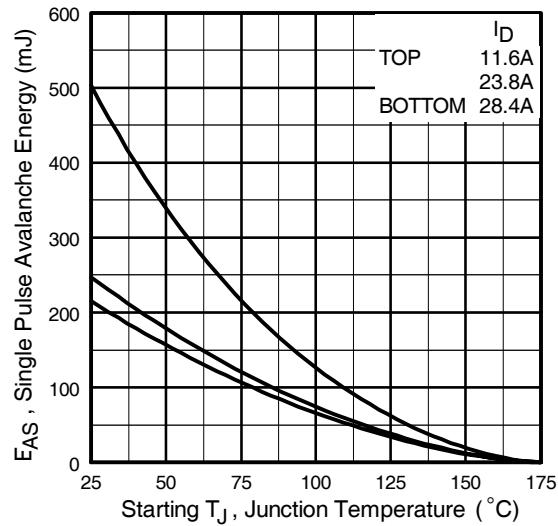
**Fig 13.** On-Resistance Vs. Gate Voltage



**Fig 14a&b.** Basic Gate Charge Test circuit and Waveforms



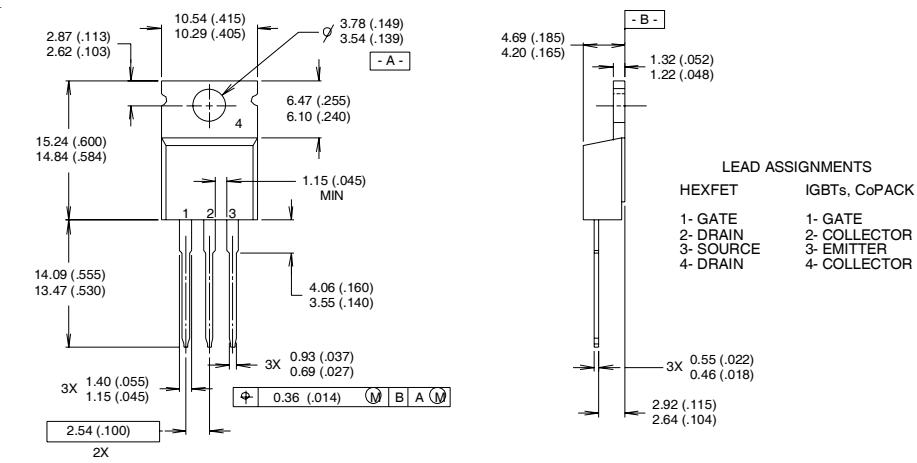
**Fig 15a&b.** Unclamped Inductive Test circuit and Waveforms



**Fig 15c.** Maximum Avalanche Energy Vs. Drain Current

## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



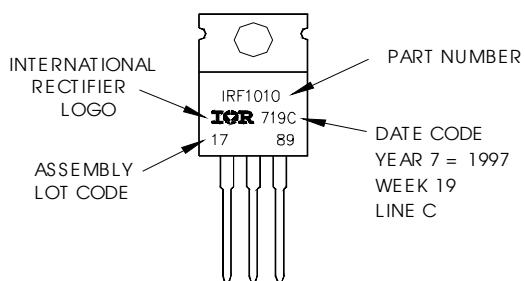
NOTES:

1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.  
 2 CONTROLLING DIMENSION : INCH

3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.  
 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 1997  
 IN THE ASSEMBLY LINE "C"  
**Note:** "P" in assembly line  
 position indicates "Lead-Free"

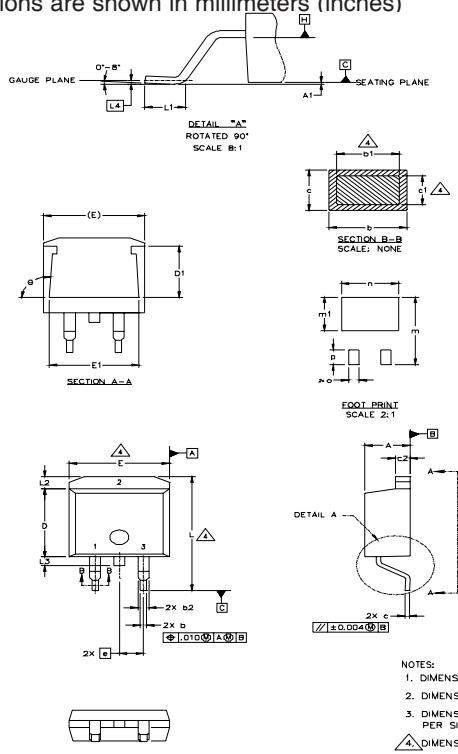


# IRF3704/S/LPbF

International  
**IR** Rectifier

## D<sup>2</sup>Pak Package Outline

Dimensions are shown in millimeters (inches)



SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	4.06	4.83	.160	.190		
A1		0.127		.005		
b	0.51	0.99	.020	.039		
b1	0.51	0.89	.020	.035	4	
b2	1.14	1.40	.045	.055		
c	0.43	0.63	.017	.025		
c1	0.38	0.74	.015	.029	4	
c2	1.14	1.40	.045	.055		
D	8.51	9.65	.335	.380	3	
D1	5.33		.210			
E	9.65	10.67	.380	.420	3	
E1	6.22		.245			
e	2.54	BSC	.100	BSC		
L	14.61	15.88	.575	.625		
L1	1.78	2.79	.070	.110		
L2			1.65	.065		
L3	1.27	1.78	.050	.070		
L4	0.25	BSC	.010	BSC		
m	17.78		.700			
m1	8.89		.350			
n	11.43		.450			
o	2.08		.082			
p	3.81		.150			
θ	90°	93°	90°	93°		

### LEAD ASSIGNMENTS

HEXFET	IGBTs, CapPACK	DIODES
1.— GATE	1.— GATE	1.— ANODE *
2.— DRAIN	2.— COLLECTOR	2.— CATHODE
3.— SOURCE	3.— Emitter	3.— ANODE

\* PART DEPENDENT.

NOTES:  
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [ .005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

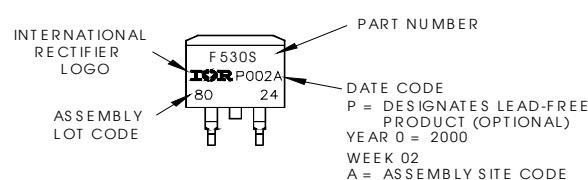
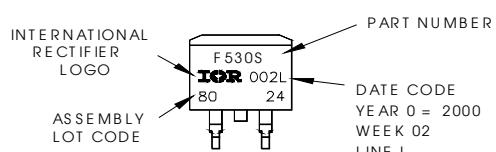
4. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.

5. CONTROLLING DIMENSION: INCH.

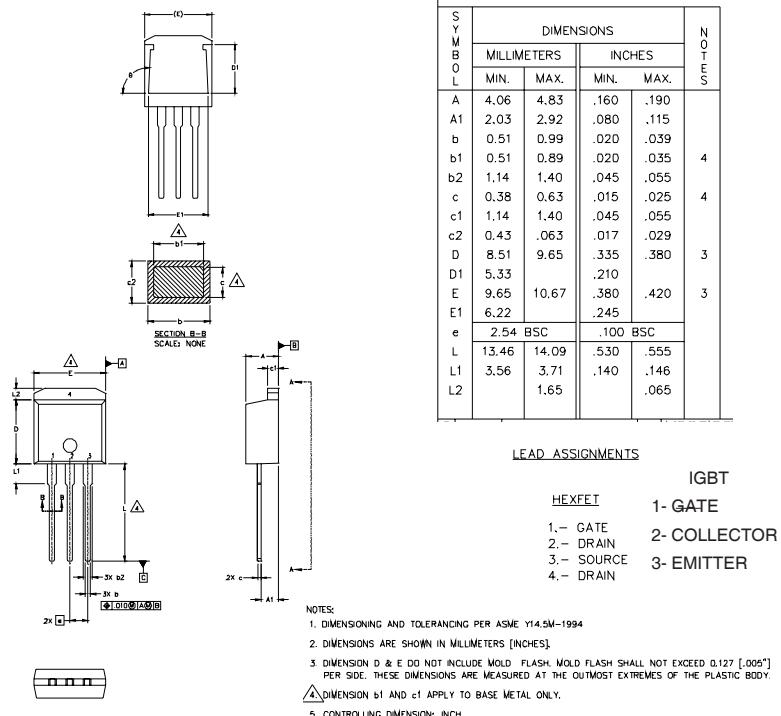
## D<sup>2</sup>Pak Part Marking Information (Lead-Free)

EXAMPLE: THIS IS AN IRF530S WITH  
LOT CODE 8024  
ASSEMBLED ON WW 02, 2000  
IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line  
position indicates "Lead-Free"



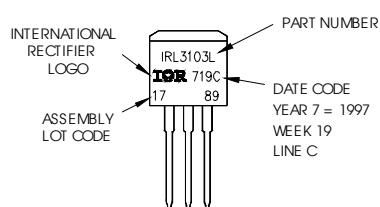
## TO-262 Package Outline



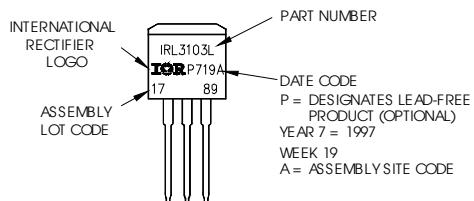
## TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 1997  
 IN THE ASSEMBLY LINE "C"

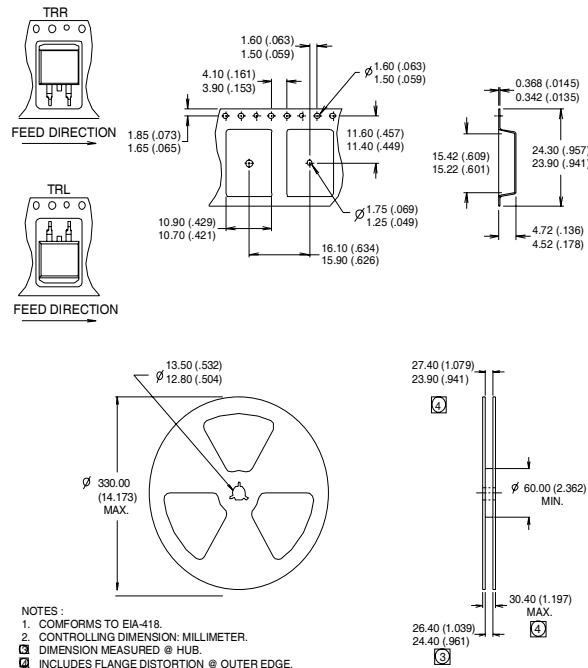
Note: "P" in assembly line  
 position indicates "Lead-Free"



OR



## D<sup>2</sup>Pak Tape & Reel Infomation



### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ③ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .
- ② Starting  $T_J = 25^\circ C$ ,  $L = 0.5 \text{ mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 28.4 \text{ A}$ .
- ④ This is only applied to TO-220AB package
- ⑤ Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.

Data and specifications subject to change without notice.

International  
**IR** Rectifier

**IR WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903  
Visit us at [www.irf.com](http://www.irf.com) for sales contact information.07/04

Note: For the most current drawings please refer to the IR website at:  
<http://www.irf.com/package/>